Features

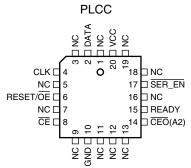
- EE Reprogrammable 2,097,152 x 1 bit Serial Memories Designed to Store Configuration Programs for Field Programmable Gate Arrays (FPGAs)
- In-System Programmable via 2-wire Bus
- Simple Interface to SRAM FPGAs
- Compatible with Atmel AT6000, AT40K FPGAs, Altera FLEX[®] Devices, ORCA[®] FPGAs, Xilinx XC3000, XC4000, XC5200, Spartan[®], Virtex[®] FPGAs
- Cascadable Read Back to Support Additional Configurations or Future Higher-density Arrays
- Low-power CMOS EEPROM Process
- Programmable Reset Polarity
- Available in PLCC Package (Pin Compatible across Product Family)
- Emulation of Atmel's AT24CXXX Serial EEPROMs
- Available in 3.3V \pm 10% LV and 5V \pm 5% C Versions
- System-friendly READY Pin
- Low-power Standby Mode

Description

The AT17C020 and AT17LV020 (high-density AT17 Series) FPGA Configuration EEPROMs (Configurators) provide an easy-to-use, cost-effective configuration memory for Field Programmable Gate Arrays. The AT17 Series is packaged in the popular 20-pin PLCC. The AT17 Series family uses a simple serial-access procedure to configure one or more FPGA devices. The AT17 Series organization supplies enough memory to configure one or multiple smaller FPGAs. The user can select the polarity of the reset function by programming internal EEPROM bytes. These devices also support a system-friendly READY pin, which signifies a "good" power level to the FPGA and can be used to ensure reliable system power-up.

The AT17 Series Configurators can be programmed with industry-standard programmers or Atmel's ATDH2200E Programming System.

Pin Configurations





2-megabit FPGA Configuration EEPROM Memory

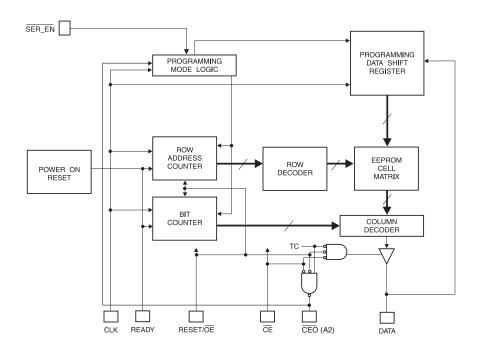
AT17C020 AT17LV020

Rev. 1239D-05/01





Block Diagram



FPGA Master Serial Mode Summary

The I/O and logic functions of the FPGA and their associated interconnections are established by a configuration program. The program is loaded either automatically upon power-up, or on command, depending on the state of the FPGA mode pins. In Master Mode, the FPGA automatically loads the configuration program from an external memory. The AT17 Serial Configuration EEPROM has been designed for compatibility with the Master Serial Mode.

This document discusses the AT40K FPGA interface. For more details or AT6K FPGA applications, please reference "AT40K Series Configuration" or "AT6000 Series Configuration" application notes.

Controlling the Highdensity AT17 Series Serial EEPROMs During Configuration

Most connections between the FPGA device and the AT17 Serial EEPROM are simple and self-explanatory:

- The DATA output of the AT17 Series Configurator drives DIN of the FPGA devices.
- The master FPGA CCLK output drives the CLK input of the AT17 Series Configurator.
- The $\overline{\text{CEO}}$ output of any AT17C/LV020 drives the $\overline{\text{CE}}$ input of the next AT17C/LV020 in a cascade chain of EEPROMs.
- SER_EN must be connected to VCC, (except during ISP).

The READY pin is available as an open-collector indicator of the device's RESET status; it is driven Low while the device is in its POWER-ON RESET cycle and released (tri-stated) when the cycle is complete.

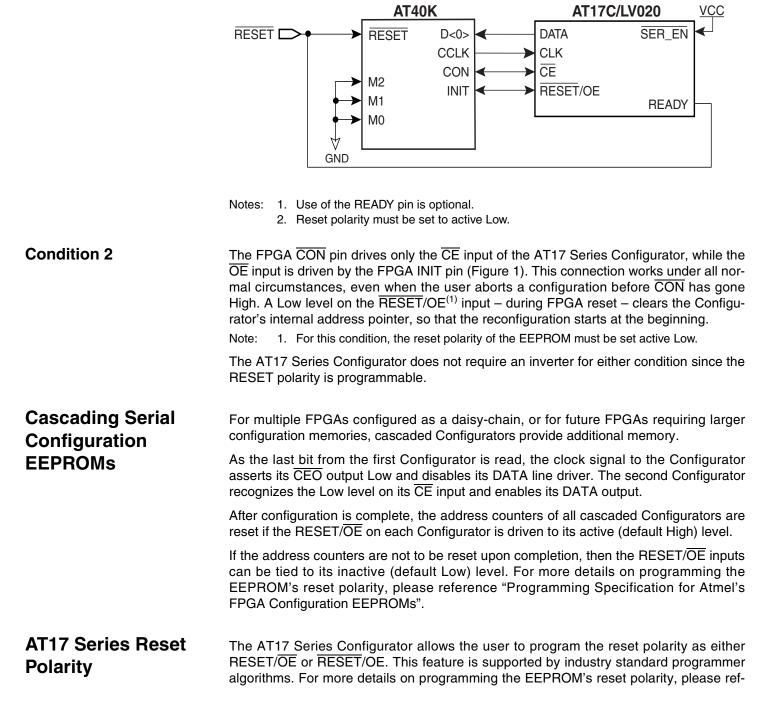
There are two different ways to use the inputs \overline{CE} and \overline{OE} .

Condition 1

The simplest connection is to have the FPGA $\overline{\text{CON}}$ pin drive both $\overline{\text{CE}}$ and $\text{RESET}/\overline{\text{OE}}^{(1)}$ in parallel. Due to its simplicity, however, this method will fail if the FPGA receives an external reset condition during the configuration cycle. If a system reset is applied to the FPGA, it will abort the original configuration and then reset itself for a new configuration, as intended. Of course, the AT17 Series Configurator does not see the external reset signal and will not reset its internal address counters and, consequently, will remain out of sync with the FPGA for the remainder of the configuration cycle.

Note: 1. For this condition, the reset polarity of the EEPROM must be set active High.









erence the "Programming Specification for Atmel's FPGA Configuration EEPROMs" application note.

Programming Mode The programming mode is entered by bringing SER_EN Low. In this mode the chip can be programmed by the 2-wire serial bus. The programming is done at VCC supply only. Programming super voltages are generated inside the chip. See the "Programming Specification for Atmel's FPGA Configuration EEPROMs" application note for further information. The AT17C parts are read/write at 5V nominal. The AT17LV parts are read/write at 3.3V nominal.

Standby Mode The AT17C/LV020 enters a low-power standby mode whenever \overline{CE} is asserted High. In this mode, the Configurator consumes less than 0.5 mA of current at 5.0 volts with CMOS level inputs. The output remains in a high impedance state regardless of the state of the \overline{OE} input.

Pin Configurations

20-pin PLCC	Name	I/O	Description
2	DATA	I/O	Three-state DATA output for configuration. Open-collector bi-directional pin for programming.
4	CLK	I	Clock input. Used to increment the internal address and bit counter for reading and programming.
6	RESET/OE	I	RESET/Output Enable input (when $\overline{\text{SER}}_{EN}$ is High). A Low level on both the $\overline{\text{CE}}$ and RESET/ $\overline{\text{OE}}$ inputs enables the data output driver. A High level on RESET/ $\overline{\text{OE}}$ resets both the address and bit counters. The logic polarity of this input is programmable as either RESET/ $\overline{\text{OE}}$ or RESET/ $\overline{\text{OE}}$.
8	CE	I	Chip Enable input. Used for device selection. A Low level on both \overline{CE} and \overline{OE} enables the data output driver. A High level on \overline{CE} disables both the address and bit counters and forces the device into a low-power standby mode. Note that this pin will <i>not</i> enable/disable the device in the 2-wire Serial Programming Mode (i.e., when \overline{SER}_{EN} is Low).
10	GND		Ground pin. A 0.2 μ F decoupling capacitor between VCC and GND is recommended.
	CEO	0	Chip Enable Output. This signal is asserted Low on the clock cycle following the last bit read from the memory. It will stay Low as long as \overline{CE} and \overline{OE} are both Low. It will then follow \overline{CE} until \overline{OE} goes High. Thereafter, \overline{CEO} will stay High until the entire EEPROM is read again.
14	A2	I	Device selection input, A2. This is used to enable (or select) the device during programming (i.e., when SER_EN is Low; see the "Programming Specification" application note for more details).
15	READY	0	Open collector reset state indicator. Driven Low during power-up reset, released when power-up is complete. (Recommend a 4.7 K Ω pull-up on this pin if used).
17	SER_EN	I	Serial enable must be held High during FPGA loading operations. Bringing SER_EN Low enables the 2-wire Serial Programming Mode.
20	VCC		+3.3V/+5V power supply pin.

Absolute Maximum Ratings*

Operating Temperature55°C to +125°C
Storage Temperature65°C to +150°C
Voltage on Any Pin with Respect to Ground0.1V to V_{CC} + 0.5V
Supply Voltage (V _{CC})0.5V to +7.0V
Maximum Soldering Temp. (10 sec. @ 1/16 in.)260°C

*NOTICE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time may affect device reliability.

Operating Conditions

			AT17	C020	AT17I	_V020	
Symbol	Description		Min	Max	Min/	Max	Units
	Commercial	Supply voltage relative to GND, -0°C to +70°C	4.75	5.25	3.0	3.6	V
V _{cc}	Industrial	Supply voltage relative to GND, -40°C to +85°C	4.5	5.5	3.0	3.6	V
	Military	Supply voltage relative to GND, -55°C to +125°C	4.5	5.5	3.0	3.6	V





DC Characteristics

Symbol	Description			Max	Units
V _{IH}	High-level input voltage		2.0	V _{cc}	V
V _{IL}	Low-level input voltage		0.0	0.8	V
V _{OH}	High-level output voltage (I _{OH} = -4 mA)	O a manufacture de la constante	3.86		V
V _{OL}	Low-level output voltage (I _{OL} = +4 mA)	Commercial		0.32	V
V _{OH}	High-level output voltage (I _{OH} = -4 mA)	lu du atrial	3.76		V
V _{OL}	Low-level output voltage (I _{OL} = +4 mA)	Industrial		0.37	V
V _{OH}	High-level output voltage (I _{OH} = -4 mA)	N dilla	3.7		V
V _{OL}	Low-level output voltage (I _{OL} = +4 mA)	Military		0.4	V
I _{CCA}	Supply current, active mode			10.0	mA
IL	Input or output leakage current ($V_{IN} = V_{CC}$ or GND)	-20.0	20.0	μA
		Commercial		0.5	mA
I _{CCS1}	Supply current, standby mode, CMOS	Industrial/Military		0.75	mA
I _{CCS2}	Supply current, standby mode, TTL	Comm./Industrial		1.0	mA

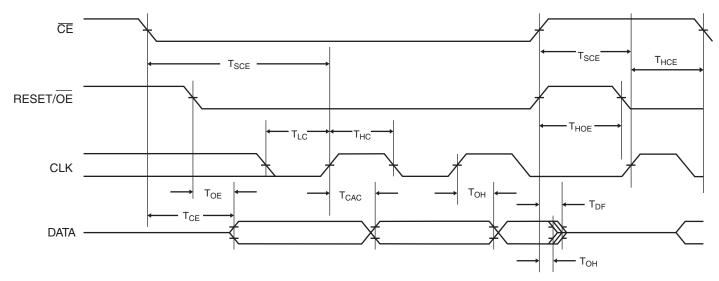
 V_{CC} = 5V \pm 5% Commercial, 5V \pm 10% Industrial/Military

DC Characteristics

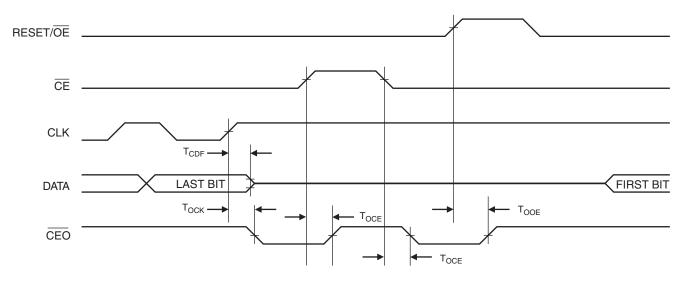
$V_{CC} = 3.3V \pm 10\%$

Symbol	Description	Min	Max	Units	
V _{IH}	High-level input voltage		2.0	V _{cc}	V
V _{IL}	Low-level input voltage		0.0	0.8	V
V _{OH}	High-level output voltage (I _{OH} = -2.5 mA)		2.4		V
V _{OL}	Low-level output voltage (I _{OL} = +3 mA)	Commercial		0.4	V
V _{OH}	High-level output voltage (I _{OH} = -2 mA)	la du dui d	2.4		V
V _{OL}	Low-level output voltage (I _{OL} = +3 mA)	Industrial		0.4	V
V _{OH}	High-level output voltage (I _{OH} = -2 mA)	N 4114	2.4		V
V _{OL}	Low-level output voltage ($I_{OL} = +2.5 \text{ mA}$)	Military		0.4	V
I _{CCA}	Supply current, active mode			5.0	mA
IL	Input or output leakage current ($V_{IN} = V_{CC}$ or GND)		-2.00	20.0	μA
		Commercial		0.2	mA
I _{CCS}	Supply current, standby mode	Industrial/Military		0.2	mA

AC Characteristics



AC Characteristics When Cascading







AC Characteristics for AT17C020

$V_{CC} = 5$	5V ± 5%	Commercial,	$V_{CC} = 5$	5V±	10%	Industrial/Military

			Commercial		Industrial/Military ⁽¹⁾	
Symbol	Description	Min	Max	Min	Max	Units
T _{OE} ⁽²⁾	OE to Data Delay		30.0		35.0	ns
$T_{CE}^{(2)}$	CE to Data Delay		45.0		45.0	ns
T _{CAC} ⁽²⁾	CLK to Data Delay		50.0		50.0	ns
Т _{ОН}	Data Hold From \overline{CE} , \overline{OE} or CLK	0.0		0.0		ns
$T_{DF}^{(3)}$	CE or OE to Data Float Delay		50.0		50.0	ns
T _{LC}	CLK Low Time	20.0		20.0		ns
T _{HC}	CLK High Time	20.0		20.0		ns
T _{SCE}	CE Setup Time to CLK (to guarantee proper counting)	20.0		25.0		ns
T _{HCE}	CE Hold Time from CLK (to guarantee proper counting)	0.0		0.0		ns
T _{HOE}	OE High Time (guarantees counter is reset)	20.0		20.0		ns
F _{MAX}	MAX Input Clock Frequency	12.5		12.5		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.

AC Characteristics for AT17C020 When Cascading

 $V_{CC} = 5V \pm 5\%$ Commercial/ $V_{CC} = 5V \pm 10\%$ Industrial/Military

		Comn	Commercial		Industrial/Military ⁽¹⁾	
Symbol	Description	Min	Max	Min	Max	Units
$T_{CDF}^{(3)}$	CLK to Data Float Delay		50.0		50.0	ns
T _{OCK} ⁽²⁾	CLK to CEO Delay		35.0		40.0	ns
T _{OCE} ⁽²⁾	CE to CEO Delay		40.0		80.0	ns
T _{OOE} ⁽²⁾	RESET/OE to CEO Delay		30.0		30.0	ns
F _{MAX}	MAX Input Clock Frequency	12.5		12.5		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.

AC Characteristics for AT17LV020

 $V_{CC}=3.3V\pm10\%$

		Commercial		Industrial/Military ⁽¹⁾		
Symbol	Description	Min	Max	Min	Max	Units
T _{OE} ⁽²⁾	OE to Data Delay		5.00		55.0	ns
T _{CE} ⁽²⁾	CE to Data Delay		55.0		60.0	ns
$T_{CAC}^{(2)}$	CLK to Data Delay		55.0		60.0	ns
Т _{ОН}	Data Hold From \overline{CE} , \overline{OE} or CLK	0.0		0.0		ns
$T_{DF}^{(3)}$	\overline{CE} or \overline{OE} to Data Float Delay		50.0		50.0	ns
T _{LC}	CLK Low Time	25.0		25.0		ns
T _{HC}	CLK High Time	25.0		25.0		ns
T _{SCE}	CE Setup Time to CLK (to guarantee proper counting)	30.0		35.0		ns
T _{HCE}	CE Hold Time from CLK (to guarantee proper counting)	0.0		0.0		ns
T _{HOE}	OE High Time (guarantees counter is reset)	25.0		25.0		ns
F _{MAX}	MAX Input Clock Frequency	12.5		7.5		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.

AC Characteristics for AT17LV020 When Cascading

 $V_{CC} = 3.3V \pm 10\%$

		Commercial		Industrial/Military ⁽¹⁾		
Symbol	Description	Min	Max	Min	Max	Units
T _{CDF} ⁽³⁾	CLK to Data Float Delay		50.0		50.0	ns
T _{OCK} ⁽²⁾	CLK to CEO Delay		50.0		55.0	ns
T _{OCE} ⁽²⁾	CE to CEO Delay		40.0		80.0	ns
T _{OOE} ⁽²⁾	RESET/OE to CEO Delay		35.0		35.0	ns
F _{MAX}	MAX Input Clock Frequency	12.5		7.5		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.





Ordering Information - 5V Devices

Memory Size	Ordering Code	Package	Operation Range
2Mb	AT17C020-10JC	20J	Commercial (0°C to 70°C)
	AT17C020-10JI	20J	Industrial (-40°C to 85°C)

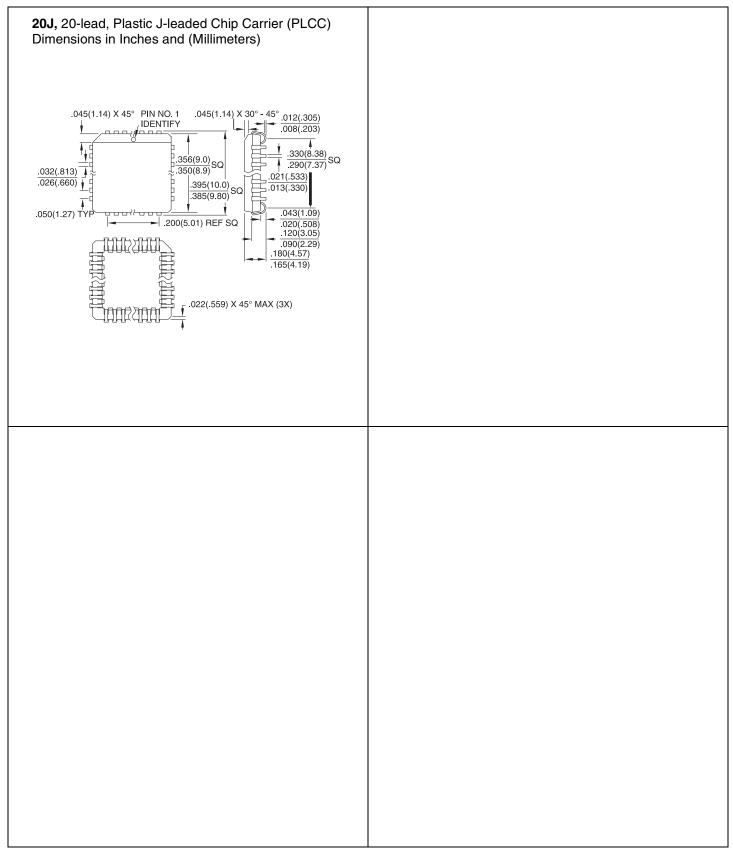
Ordering Information - 3.3V Devices

Memory Size	Ordering Code	Package	Operation Range
2Mb	AT17LV020-10JC	20J	Commercial (0°C to 70°C)
	AT17LV020-10JI	20J	Industrial (-40°C to 85°C)

	Package Type	
20J	20-lead, Plastic J-leaded Chip Carrier (PLCC)	

AT17C/LV020

Packaging Information







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FAQ

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